

RF EXPOSURE Test Report

Report No.: MTi240801021-16E3

Date of issue: 2024-09-26

Applicant: YI ZHAO (SHENZHEN) CO., LIMITED

Product: E900 BT

Model(s): E900BT, E1000WT, E1000 WT, E900 X,

E5000 BT, E5000 X

FCC ID: 2A25A-E900BT

Shenzhen Microtest Co., Ltd.

http://www.mtitest.cn

Address: 101, No. 7, Zone 2, Xinxing Industrial Park, Fuhai Avenue, Xinhe Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China.

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	TEST RESU	ILT CERTIFICATION			
Applicant: YI ZHAO (SHENZHEN) CO., LIMITED					
Address:	6th Floor, T3 Creative Hangcheng Street, Ba	Building, Creative Expo City, No.5010 Baoan Avenue, oan Shenzhen, China			
Manufacturer:	turer: YI ZHAO (SHENZHEN) CO., LIMITED				
Address:	Expo City, No.5010 Ba	h Floor, T3 Creative Building, Shenzhen Colorful Huiwei Cultural and Creative po City, No.5010 Baoan Avenue, Caowei Community, Hangcheng Street, loan District, Shenzhen City, Guangdong Province, China			
Factory:	YI ZHAO (SHENZHEN)	YI ZHAO (SHENZHEN) CO., LIMITED			
Address:	6th Floor, T3 Creative Building, Shenzhen Colorful Huiwei Cultural and Creative Expo City, No.5010 Baoan Avenue, Caowei Community, Hangcheng Street, Baoan District, Shenzhen City, Guangdong Province, China				
Product description	า				
Product name:	E900 BT				
Trademark:	EKSA	EKSA			
Model Name:	E900BT	E900BT			
Serial Model	E1000WT, E1000 WT	E1000WT, E1000 WT, E900 X, E5000 BT, E5000 X			
Standards:	N/A				
Test procedure:	KDB 447498 D01 v06				
Date of Test	,				
Date (s) of performance of tests:		2024-08-14 to 2024-09-26			
Test Result:		Pass			

Test Engineer	:	Marlean Tony
		(Maleah Deng)
Reviewed By	:	Dowid. Cel
		(David Lee)
Approved By	:	leor chen
		(Leon Chen)

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1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Test Exclusion Threshold condition(s), listed below, is (are) satisfied.

These test exclusion conditions are based on source-based time-averaged maximum conducted output power of the RF channel requiring evaluation, adjusted for tune-up tolerance, and the minimum test separation distance required for the exposure conditions.

The minimum test separation distance defined in 4.1 f) is determined by the smallest distance from the antenna and radiating structures or outer surface of the device, according to the host form factor, exposure conditions and platform requirements, to any part of the body or extremity of a user or bystander.

To qualify for SAR test exclusion, the test separation distances applied must be fully explained and justified, typically in the SAR measurement or SAR analysis report, by the operating configurations and exposure conditions of the transmitter and applicable host platform requirements, according to the required published RF exposure KDB procedures.

When no other RF exposure testing or reporting are required, a statement of justification and compliance must be included in the equipment approval, in lieu of the SAR report, to qualify for SAR test exclusion.

When required, the device specific conditions described in the other published RF exposure KDB procedures must be satisfied before applying these SAR test exclusion provisions.

a) For 100 MHz to 6 GHz and test separation distances ≤ 50 mm, the 1-g and 10-g SAR test exclusion thresholds are determined by the following:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR, and ≤ 7.5 for 10-g extremity SAR, where

- f_(GHz) is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison
- The values 3.0 and 7.5 are referred to as *numeric thresholds* in step b) below

The test exclusions are applicable only when the minimum test separation distance is \leq 50 mm, and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to 4.1 f) is applied to determine SAR test exclusion.

- b) For 100 MHz to 6 GHz and test separation distances > 50 mm, the 1-g and 10-g SAR test exclusion thresholds are determined by the following (also illustrated in Appendix B):
 - 1) {[Power allowed at *numeric threshold* for 50 mm in step a)] + [(test separation distance 50 mm)·(f(MHz)/150)]} mW, for 100 MHz to 1500 MHz
 - 2) {[Power allowed at numeric threshold for 50 mm in step a)] + [(test separation distance 50 mm)·10]} mW, for > 1500 MHz and ≤ 6 GHz
- c) For frequencies below 100 MHz, the following may be considered for SAR test exclusion (also illustrated in Appendix C):
 - 1) For test separation distances > 50 mm and < 200 mm, the power threshold at the corresponding test separation distance at 100 MHz in step b) is multiplied by [1 + log(100/f(MHz))]

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- 2) For test separation distances ≤ 50 mm, the power threshold determined by the equation in c) 1) for 50 mm and 100 MHz is multiplied by ½
- 3) SAR measurement procedures are not established below 100 MHz.

When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any SAR test results below 100 MHz to be acceptable.

2. SAR Test Exclucsion Thresholds

We use 5mm as separation distance to calculated.

Bluetooth DSS:

Transmit Frequency (GHz)	Mode	Measured Power (dBm)	Tune-up power (dBm)	Max tune-up	Result	1g SAR test
				power(dBm)	calculation	exclusion threshold
2.402		-18.22	(-18)±1	-17	0.0062	3
2.441	GFSK	-18.46	(-18)±1	-17	0.0062	3
2.480		-19.04	(-19)±1	-18	0.0050	3
2.402		-17.41	(-17)±1	-16	0.0078	3
2.441	π/4-DQPSK	-17.65	(-17)±1	-16	0.0078	3
2.480		-18.19	(-18)±1	-17	0.0063	3

2.4G SRD:

Transmit Frequency (GHz)	Mode	Measured Power (dBm)	Tune-up power (dBm)	Max tune-up	Result	1g SAR test
				power(dBm)	calculation	exclusion threshold
2.402		-18.22	(-18)±1	-17	0.0062	3
2.441	GFSK	-18.39	(-18)±1	-17	0.0062	3
2.480		-19.00	(-19)±1	-18	0.0050	3
2.402		-17.08	(-17)±1	-16	0.0078	3
2.441	π/4-DQPSK	-17.44	(-17)±1	-16	0.0078	3
2.480		-18.03	(-18)±1	-17	0.0063	3

Conclusion:

2.4G SRD and Bluetooth cannot work simultaneously

For the max result: 0.0078≤ 3.0 1g SAR test exclusion threshold, No SAR is required.

----END OF REPORT----

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